

<b>Notice of References Cited</b>	Application/Control No. 10/757,253		Applicant(s)/Patent Under Reexamination EPPICH ET AL.	
	Examiner Hsien-Ming Lee		Art Unit 2823	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,319,832	11-2001	Uhlenbrock et al.	438/681
X	B	US-6,277,702	08-2001	Chun et al.	438/396
X	C	US-6,617,210	09-2003	Chau et al.	438/240
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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